IN THE CLAIMS:

Claim 1 (Currently Amended): An array substrate for a liquid crystal display device, comprising:

a substrate;

a plurality of gate lines arranged transversely on the substrate;

a plurality of data lines disposed orthogonal to the plurality of gate lines;

of the gate lines and the data lines, each thin film transistor including a gate electrode, a gate insulation layer, an active layer, an ohmic contact layer, a source electrode, and a

a plurality of thin film transistors formed on the substrate adjacent to intersections

drain electrode, the source electrode extended from each of the data lines and overlapping

a portion of the gate electrode;

a plurality of pixel electrodes disposed at pixel regions defined by the intersections of the gate lines and the data lines, each pixel electrode connected to a corresponding one of the drain electrodes; and

a metal layer formed on an entire surface of each of the data lines and an entire surface of the source electrode, and at peripheral portions of the drain electrode,

wherein the drain electrode and the pixel electrodes are formed from the same material, and

wherein the source electrode is positioned between the ohmic contact layer and the metal layer and formed of a transparent conductive material. Claim 2 (Original): The array substrate according to claim 1, wherein the gate insulation

layer is disposed on the gate electrode.

Claim 3 (Original): The array substrate according to claim 1, wherein the active layer is

disposed on the gate insulation layer, and the ohmic contact layer is disposed on the

active layer.

Claim 4 (Original): The array substrate according to claim 1, wherein the source

electrode and the drain electrode are disposed on the ohmic contact layer.

Claim 5 (Original): The array substrate according to claim 4, wherein the source

electrode extends from one of the data lines.

Claim 6 (Original): The array substrate according to claim 4, wherein the drain electrode

extends from one of the pixel electrodes.

Claim 7 (Original): The array substrate according to claim 4, wherein the drain electrode

and source electrode include at least a transparent conductive material.

Claim 8 (Original): The array substrate according to claim 7, wherein each data line

includes at least the transparent conductive material.

Claim 9 (Original): The array substrate according to claim 7, wherein each pixel

electrode includes the transparent conductive material.

Claim 10 (Original): The array substrate according to claim 7, wherein the transparent

conductive material is selected from a group including indium tin oxide, indium zinc

oxide, zinc oxide, thin oxide and indium oxide.

Claim 11 (Original): The array substrate according to claim 1, wherein the gate

insulation layer is disposed on the plurality of gate lines.

Claim 12 (Original): The array substrate according to claim 1, wherein the metal layer is

selected from a group including aluminum (Al), copper (Cu), gold (Au) and silver (Ag).

Claim 13 (Original): The array substrate according to claim 12, wherein the metal layer

is formed on an entire surface of the source electrode.

Claim 14 (Original): The array substrate according to claim 12, wherein the metal layer

is formed at peripheral portions of the plurality of pixel electrodes.

Claim 15 (Canceled).

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Claim 16 (Withdrawn): A method of fabricating an array substrate for a liquid crystal

forming a first metal layer on a substrate;

display device, comprising the steps of:

forming a gate line and a gate electrode;

forming a gate insulation layer to cover the first metal layer;

forming a pure amorphous silicon layer and a doped amorphous silicon layer on the gate insulation layer;

forming an ohmic contact layer and an active layer over the gate electrode;

forming a transparent conductive material on the gate insulation layer to cover the active layer and the ohmic contact layer;

forming a photoresist layer on the transparent conductive material;

patterning the photoresist layer using a mask;

forming a data line, a pixel electrode, a source electrode and a drain

electrode: and

forming a second metal layer on an entire surface of the data line.

Claim 17 (Withdrawn): The method according to claim 16, wherein the step of forming the gate line and the gate electrode includes patterning the first metal layer.

Claim 18 (Withdrawn): The method according to claim 16, wherein the step of forming the ohmic contact layer and the active layer includes patterning the doped amorphous silicon layer and the pure amorphous silicon layer.

Claim 19 (Withdrawn): The method according to claim 16, wherein the mask includes a

plurality of slits and a plurality of light shielding areas.

Claim 20 (Withdrawn): The method according to claim 16, wherein the step of forming

the data line, the pixel electrode, the source electrode, and the drain electrode includes

patterning the transparent conductive material using a dry etching process.

Claim 21 (Withdrawn): The method according to claim 20, wherein the step of

patterning the transparent conductive material includes removing a first photoresist layer

formed on the data line and the source electrode while etching exposed portions of the

transparent conductive material, and removing peripheral portions of a second photoresist

layer formed on the drain electrode and the pixel electrode while etching the exposed

portions of the transparent conductive material.

Claim 22 (Withdrawn): The method according to claim 16, further including the step of

forming the second metal layer on an entire surface of the source electrode.

Claim 23 (Withdrawn): The method according to claim 16, further including the step of

forming the second metal layer at peripheral portions of the pixel electrode and the drain

electrode.

Claim 24 (Withdrawn): The method according to claim 16, wherein the step of

patterning the photoresist layer includes aligning the mask over the photoresist layer,

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exposing light through a plurality of slits of the mask; and developing the photoresist

layer to expose the transparent conductive material.

Claim 25 (Withdrawn): The method according to claim 16, wherein the step of forming

the second metal layer includes electroplating a second metal material on the data line.

electroplating the second metal material on the source electrode, electroplating the second

metal material on peripheral portions of the pixel electrode, electroplating the second

metal material on peripheral portions of the drain electrode, and removing the photoresist

layer from the transparent conductive material.

Claim 26 (Withdrawn): The method according to claim 16, wherein the source electrode

extends from one of the data lines.

Claim 27 (Withdrawn): The method according to claim 16, wherein the drain electrode

extends from one of the pixel electrodes.

Claim 28 (Withdrawn): The method according to claim 16, wherein the transparent

conductive material is selected from a group including indium tin oxide, indium zinc

oxide, zinc oxide, thin oxide and indium oxide.

Claim 29 (Withdrawn): The method according to claim 16, wherein the second metal

layer is selected from a group including aluminum(Al), copper(Cu), gold (Au) and silver

(Ag).

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